

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/774,321	LIN ET AL.	
Examiner		Art Unit		Page 1 of 1
Fadey S. Jabr		3628		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0097059 A1	05-2005	Shuster, Gary Stephen	705/059
*	B	US-2004/0261070 A1	12-2004	Miller et al.	717/170
*	C	US-2004/0194077 A1	09-2004	Bharadwaj et al.	717/158
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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